

Experimental study of the adaptive gain feature for improved position-sensitive ion spectroscopy with Timepix2

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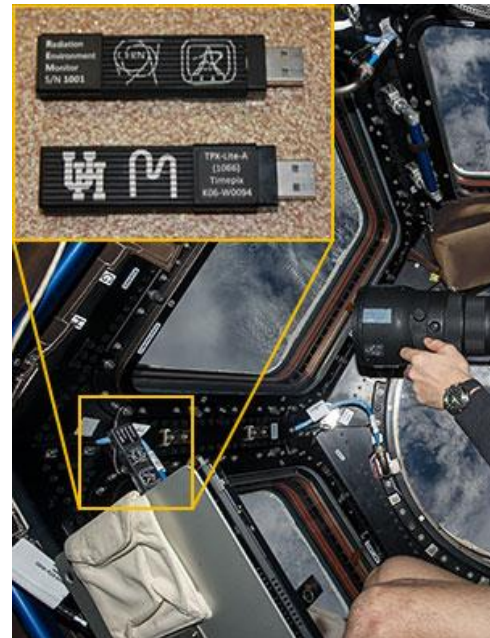
²) Faculty of Electrical Engineering, University of West Bohemia

³) Advacam s.r.o, Advacam Oy.

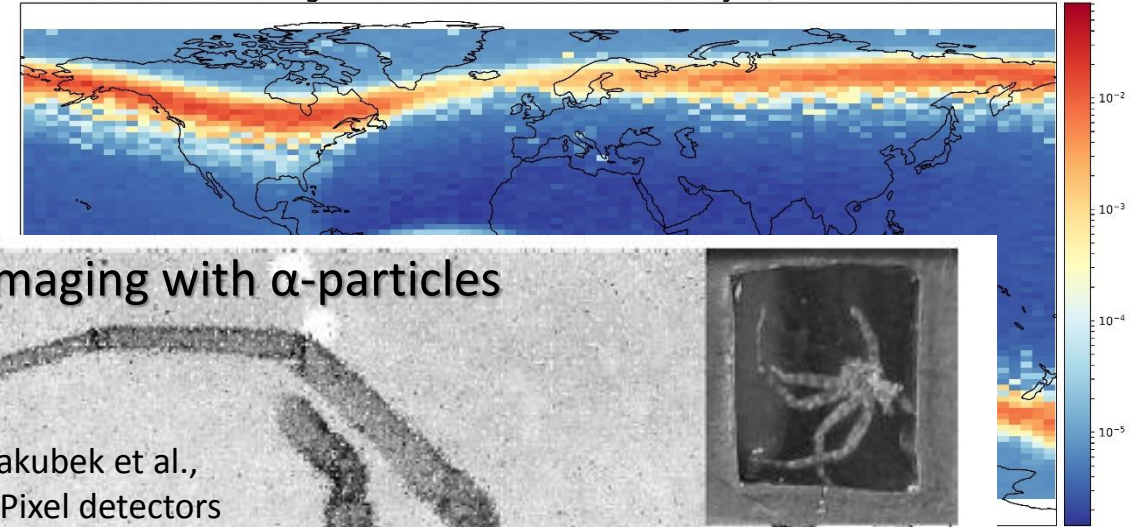
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Motivation – Timepix applications

- Radiation field characterization and dosimetry in
 - Space application
 - Nuclear and particle physics experiment
 - Hadron therapy
- Imaging
 - X-rays
 - Neutrons
 - Alphas

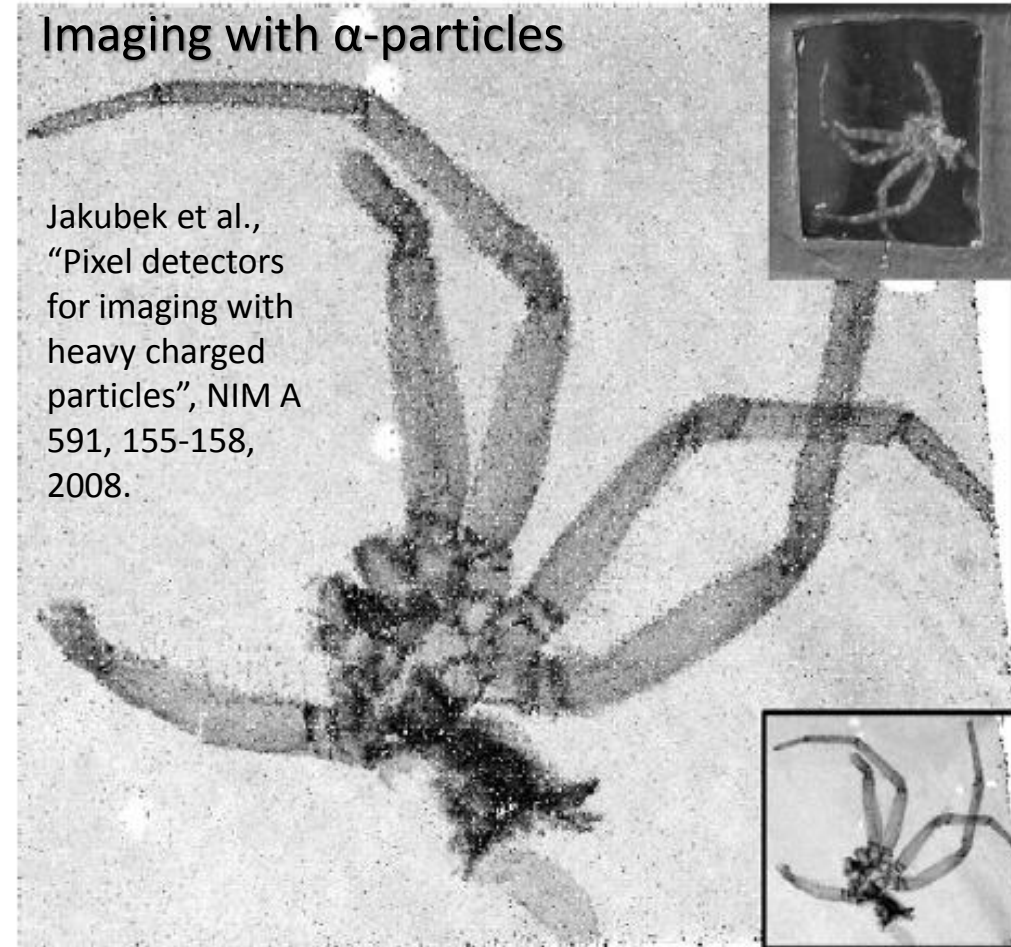


SATRAM - Average dose rate 2015-2018 (mGy/h) - Orbit: 820 km

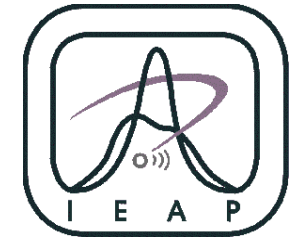


Imaging with α -particles

Jakubek et al.,
“Pixel detectors
for imaging with
heavy charged
particles”, NIM A
591, 155-158,
2008.



Timepix2 – improved capabilities



256 x 256 pixels

Pixel pitch 55 μm

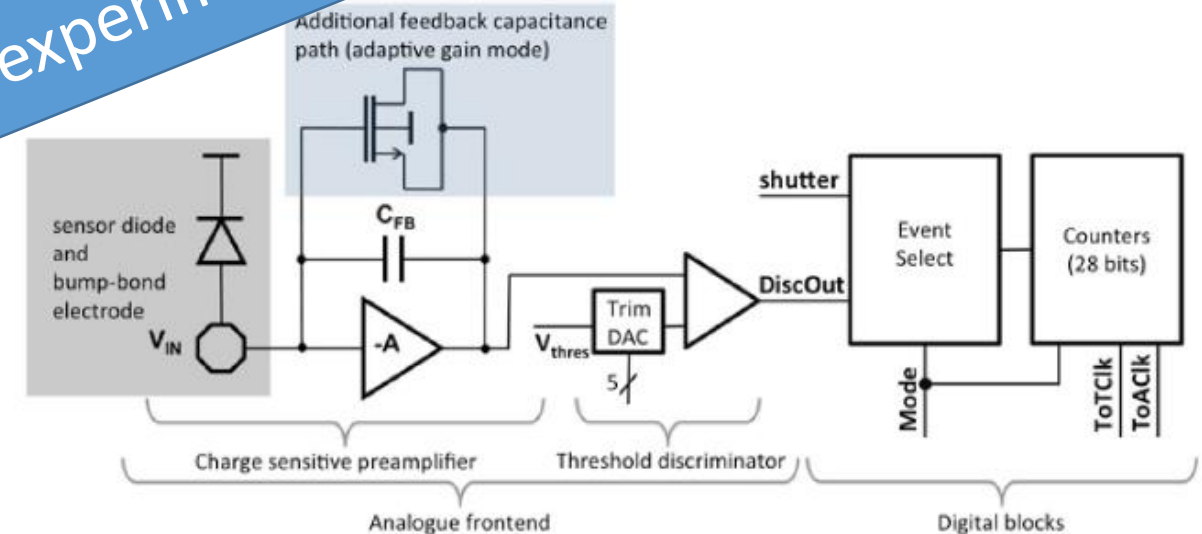
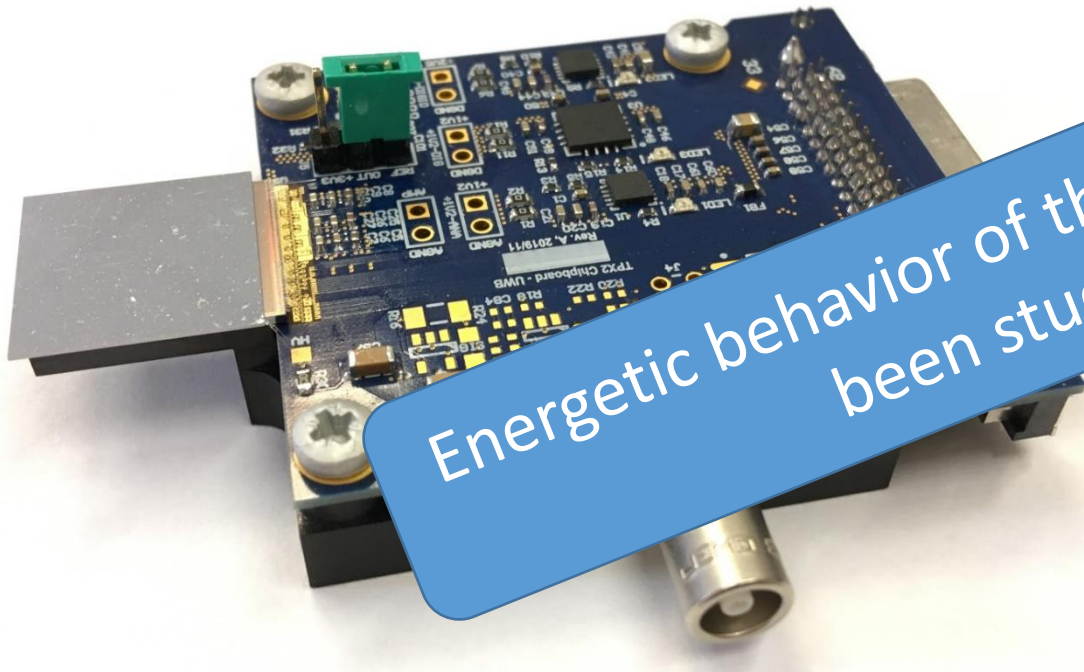
Frame-based readout scheme

Silicon sensor of 300 μm

Improvements (among others):

- ToT is not cut by the shutter signal
- Simultaneous ToT and ToA measurement
- Frame occupation monitoring and per frame termination
- Power consumption reduction
- Dynamic range is increased due to

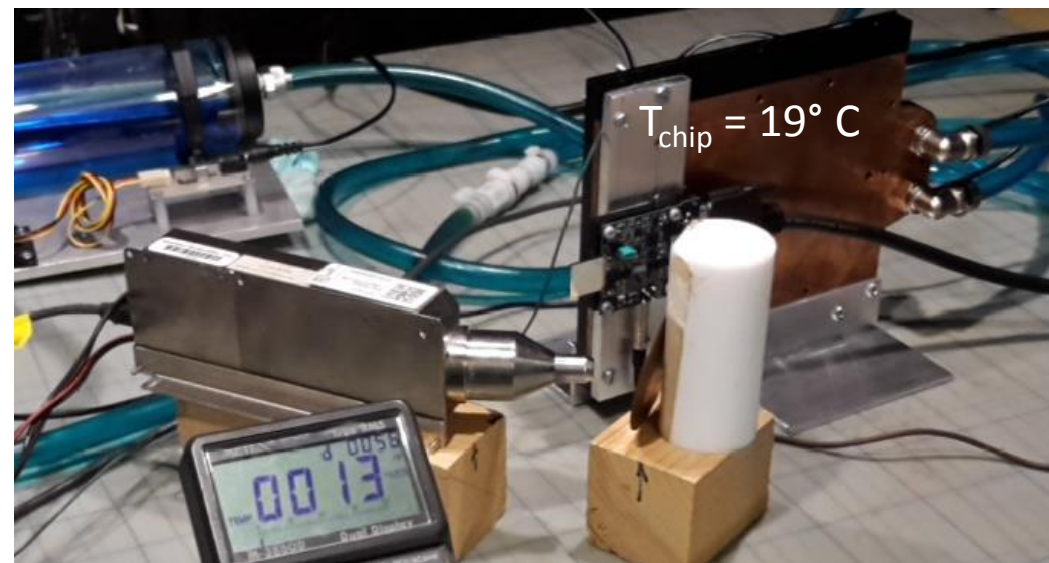
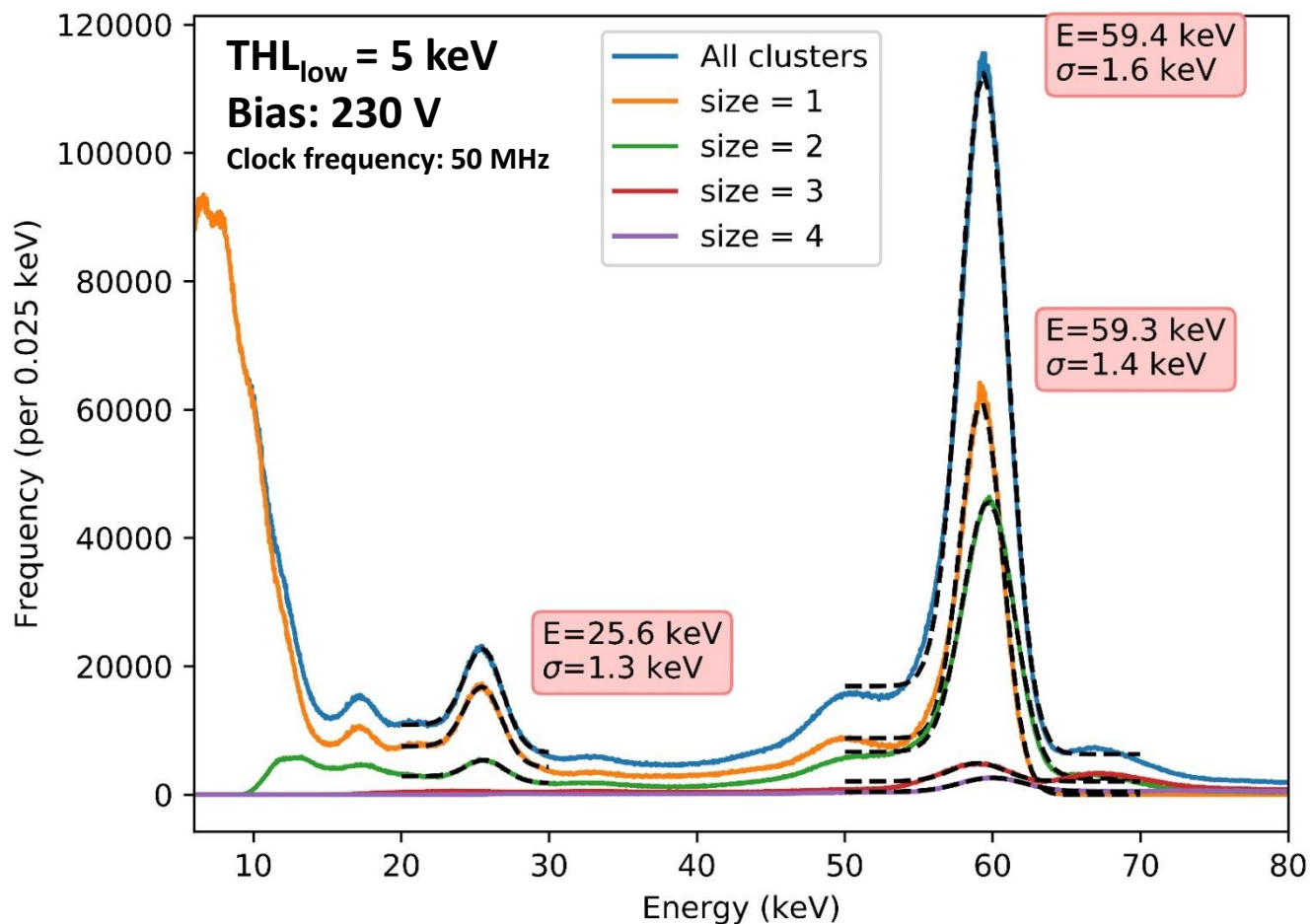
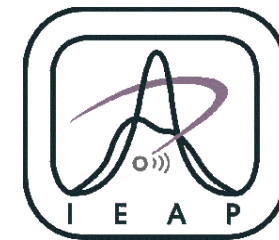
Energetic behavior of the adaptive gain feature has not been studied experimentally



Calibrations with photons

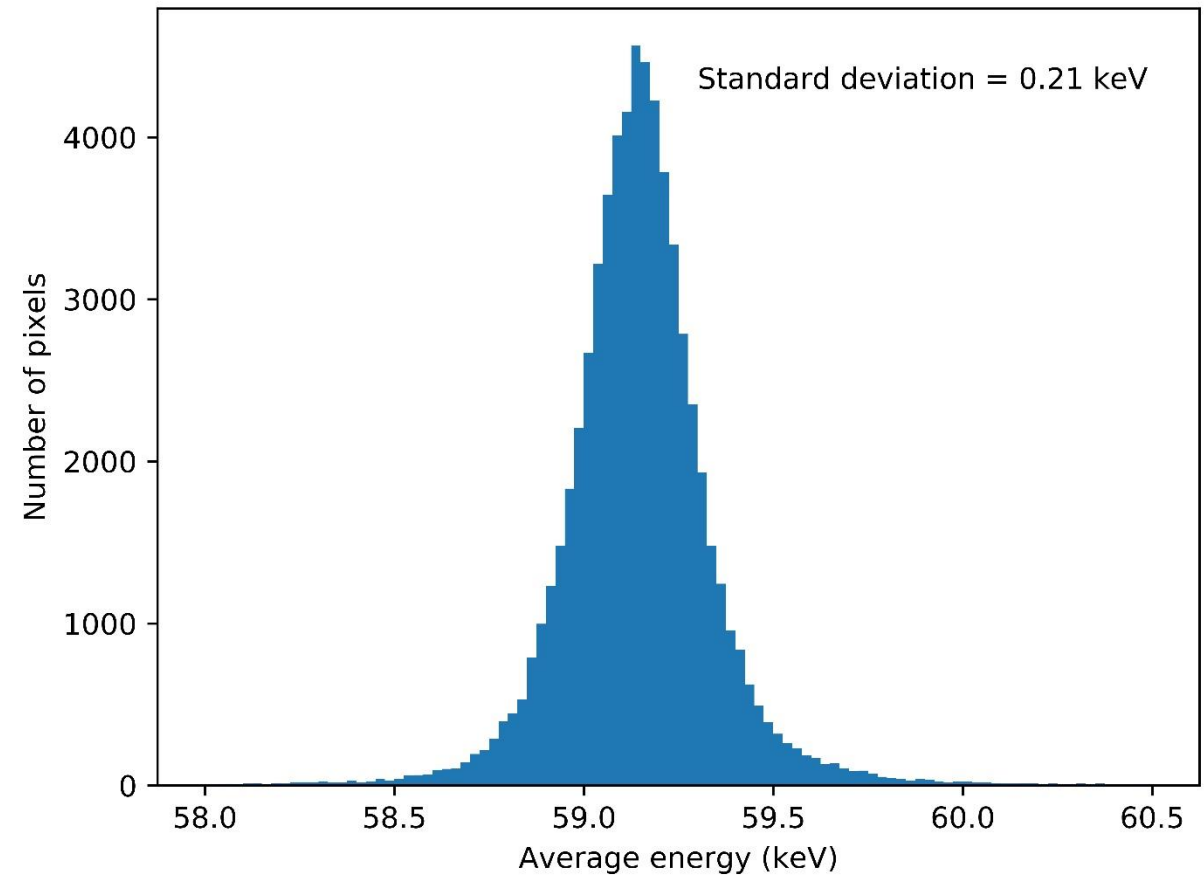
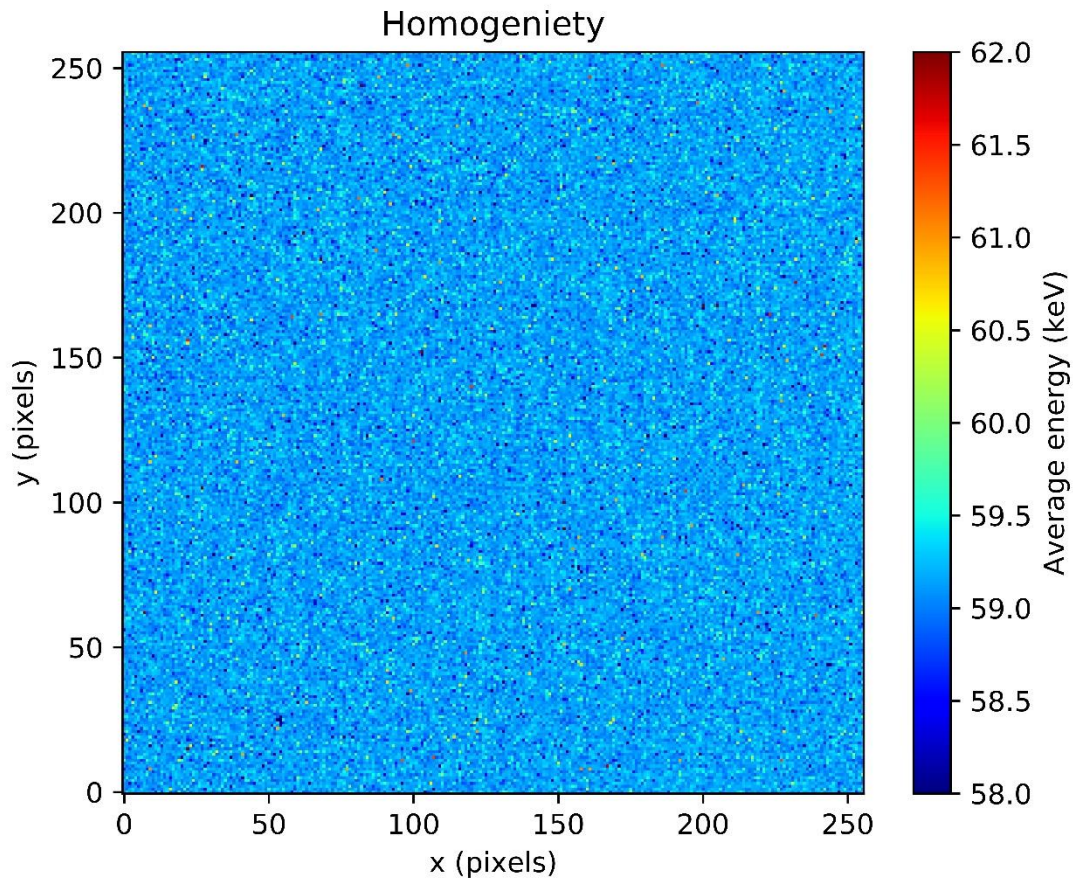
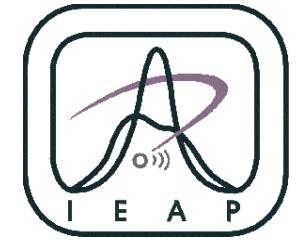
Energy calibration with photons:

Per-pixel ToT calibration results



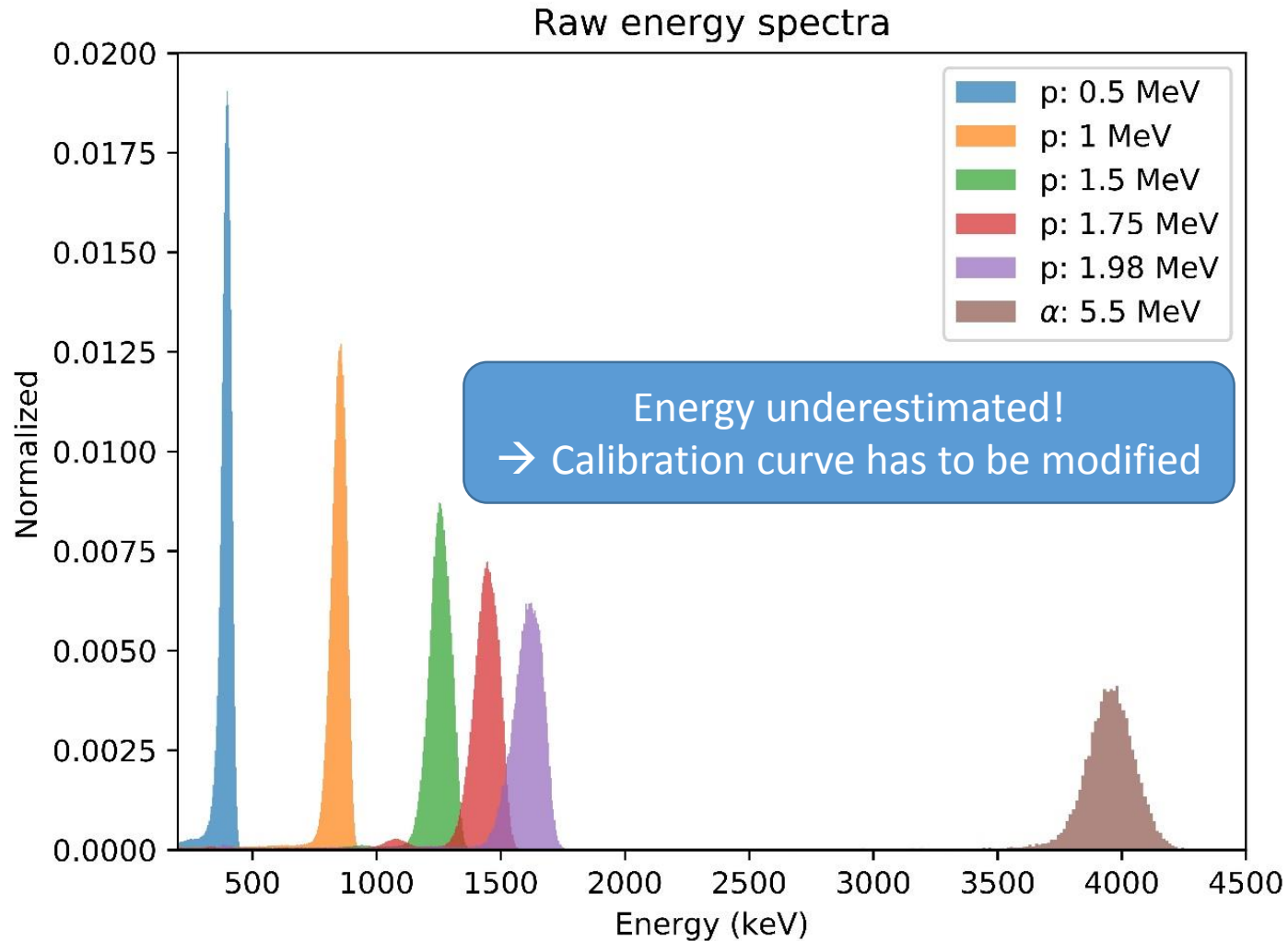
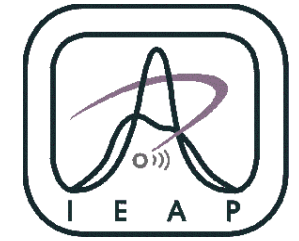
- Katherine readout system used for detector control
- Calibration XRF from Cu, Cd, and gammas from ^{241}Am with single pixel clusters

Per-pixel ToT calibration results - homogeneity

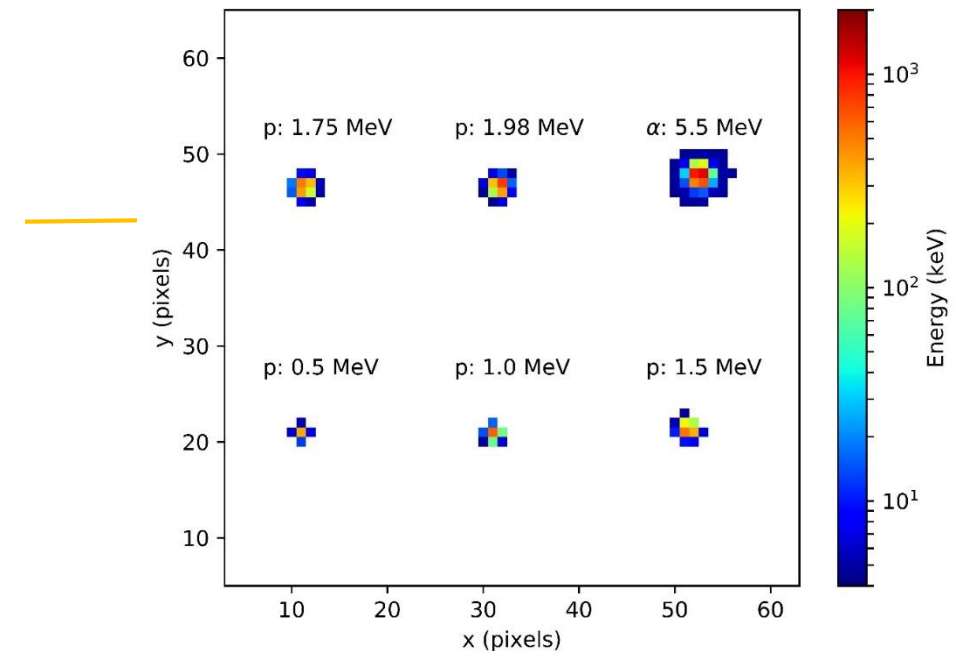


Determination of the pixels' high energy behavior

Measurement at Van-de-Graaff: Measurement setup

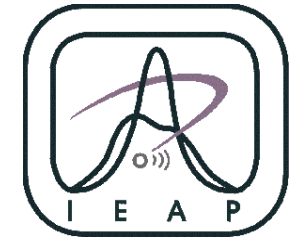


- Tunable source of monoenergetic protons in the range from 500 keV – 2 MeV.
- 5.5 MeV α -particles from a ^{241}Am source

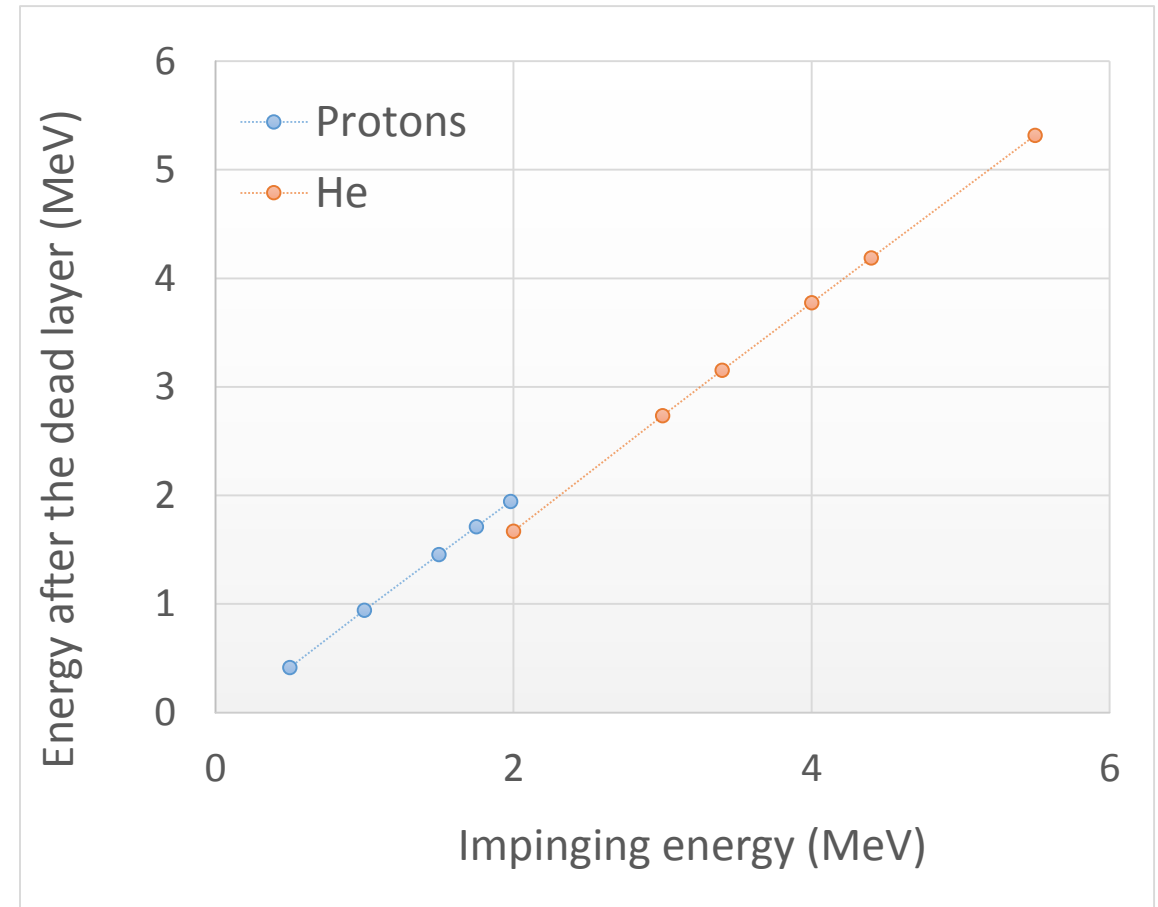
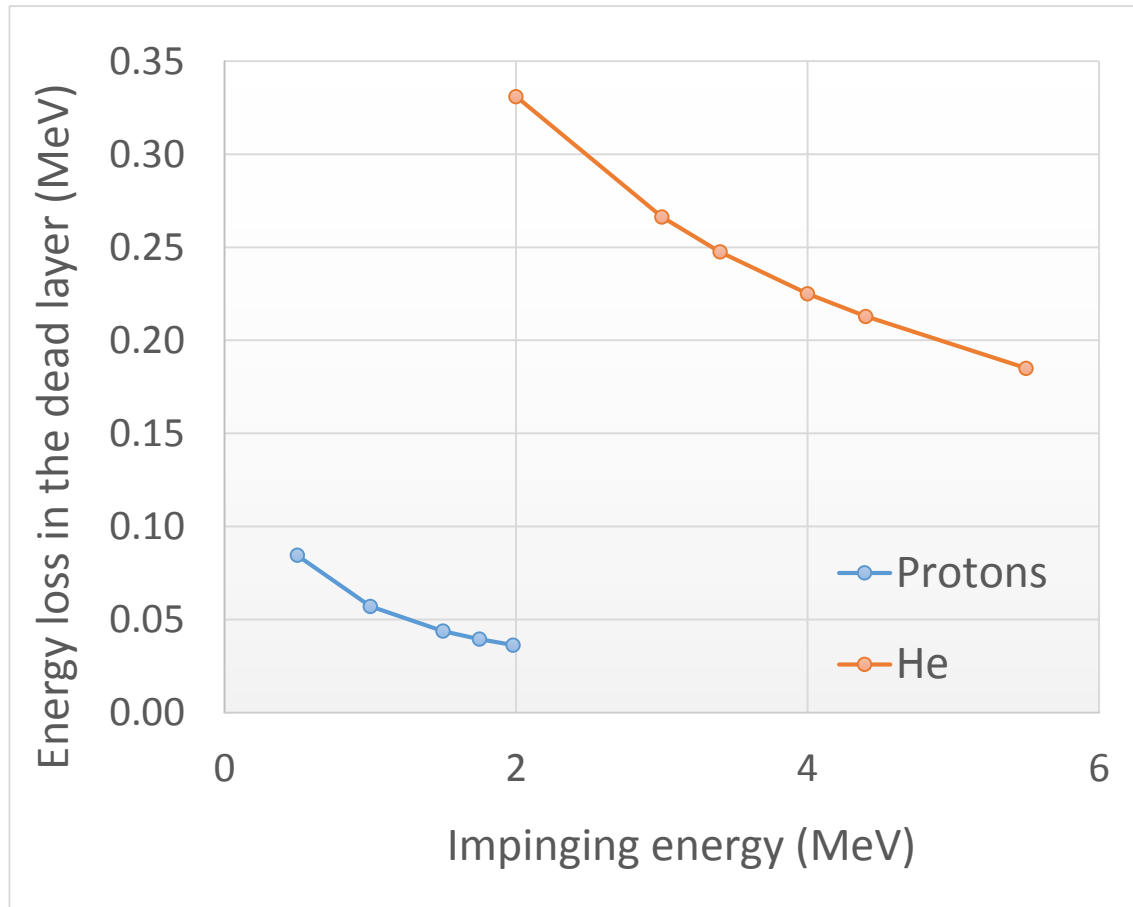


Determination of nominal energies:

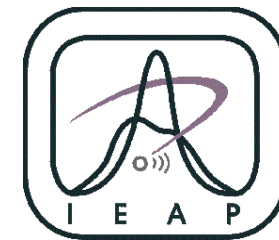
Energy losses in the dead material at the backside contact



Energy losses simulated with SRIM
500 nm thick aluminum, 800 nm thick silicon



Strategy for the high energy calibration

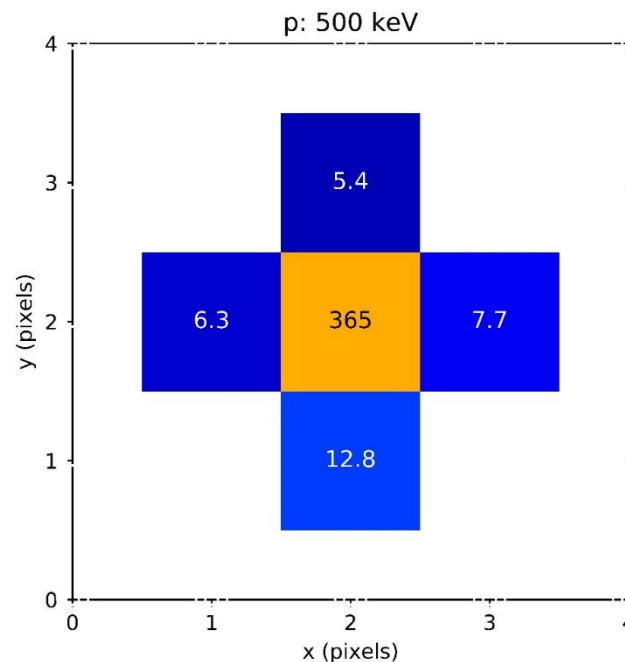


Problem: Deposited energy of protons and alphas does not stay in a single pixel

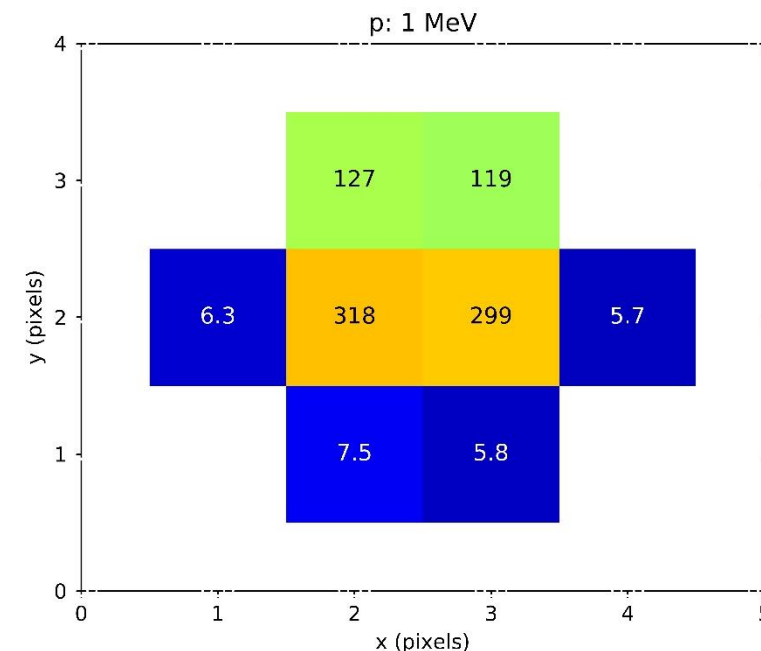
Strategy:

1. Start with low energy protons and search for clusters few pixels are in the “uncalibrated” ($E > 150$ keV) energy region
2. Assign the missing energy to the latter pixels to create a global calibration curve

Examples:

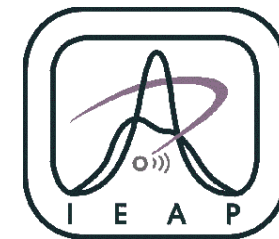


$E_{\text{meas}} = 397$ keV, $E_{\text{expected}} = 420$ keV
1 pixel with $E_{\text{pix}} > 150$ keV
→ Plot $(E_{\text{expected}} - E_{\text{meas}})$ vs E_{pix}

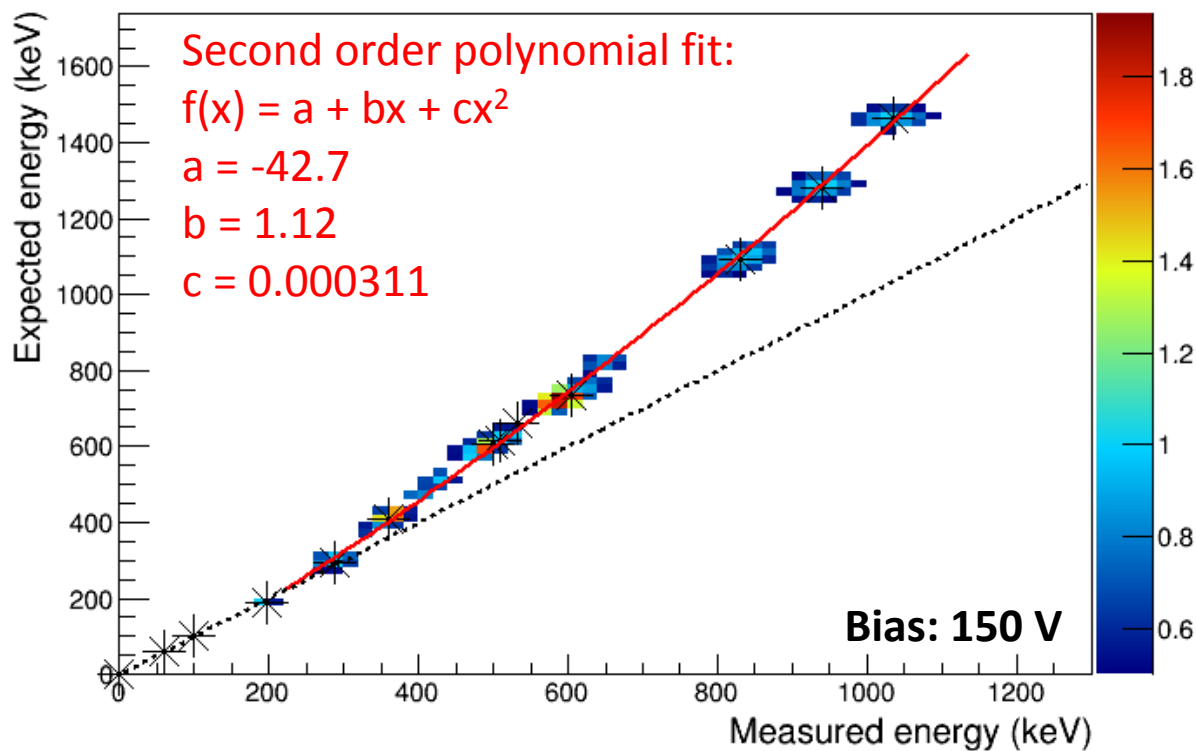


$E_{\text{meas}} = 888$ keV, $E_{\text{expected}} = 940$ keV
2 pixel with $E_{\text{pix}} > 150$ keV
→ Plot $(E_{\text{expected}} - E_{\text{meas}})/2$ vs $\langle E_{\text{pix}} \rangle$

Calibration correction curves determination: Global energy correction function



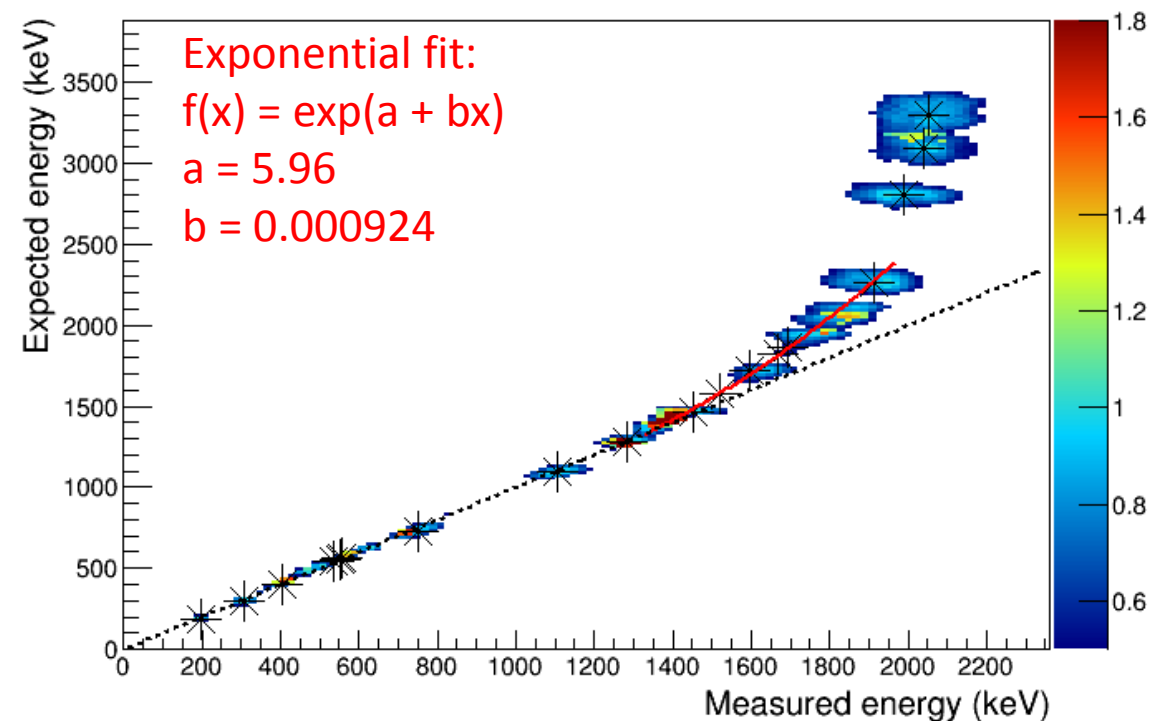
Protons at Van-de-Graaff



- Different per-pixel energy depositions achieved by tuning the energy of the protons.
- Energy assumed to be correctly measured with current calibration up to 150 keV

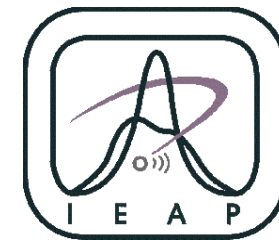
- Different per-pixel energy depositions achieved by varying the bias voltage.
- Energy assumed correct up to 1000 keV

Protons at Van-de-Graaff and 5.5 MeV α particles

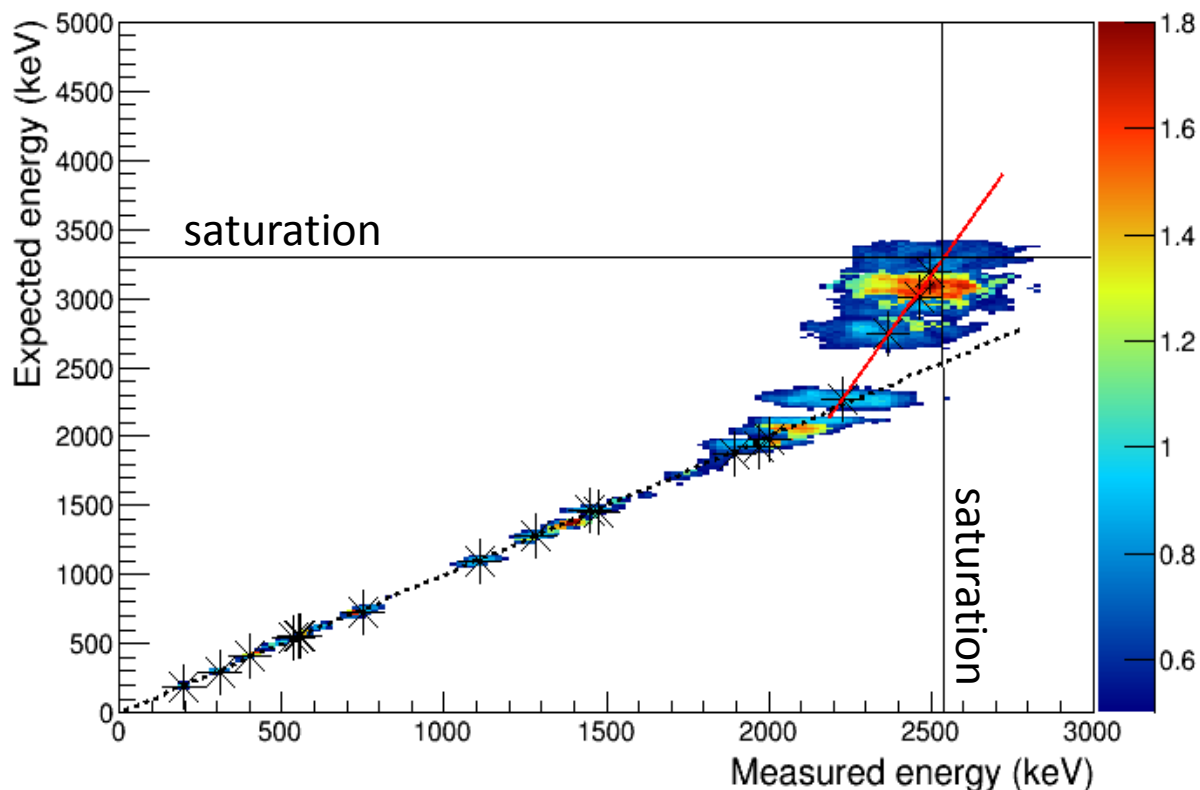


Calibrated pixel energy response:

Comparison with design simulation

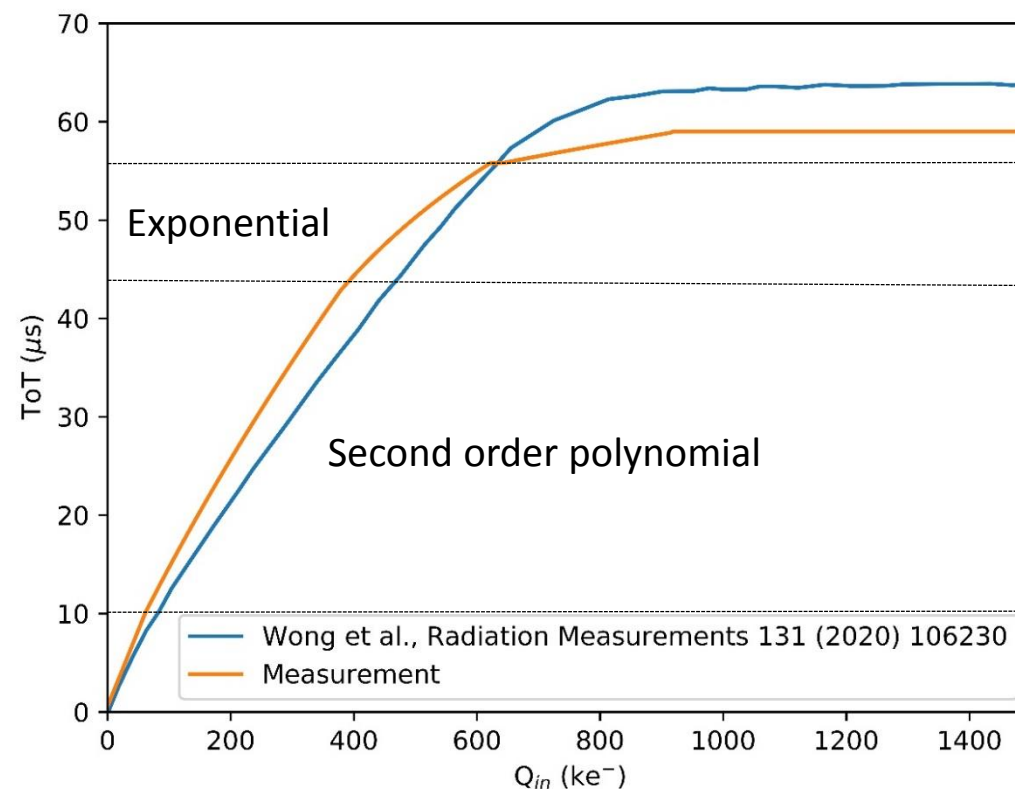


Corrected pixel response



- Energy measurement up to ~ 2.2 MeV in each pixel.
- The per-pixel saturation level is 3.3 MeV (916 ke $^{-}$)

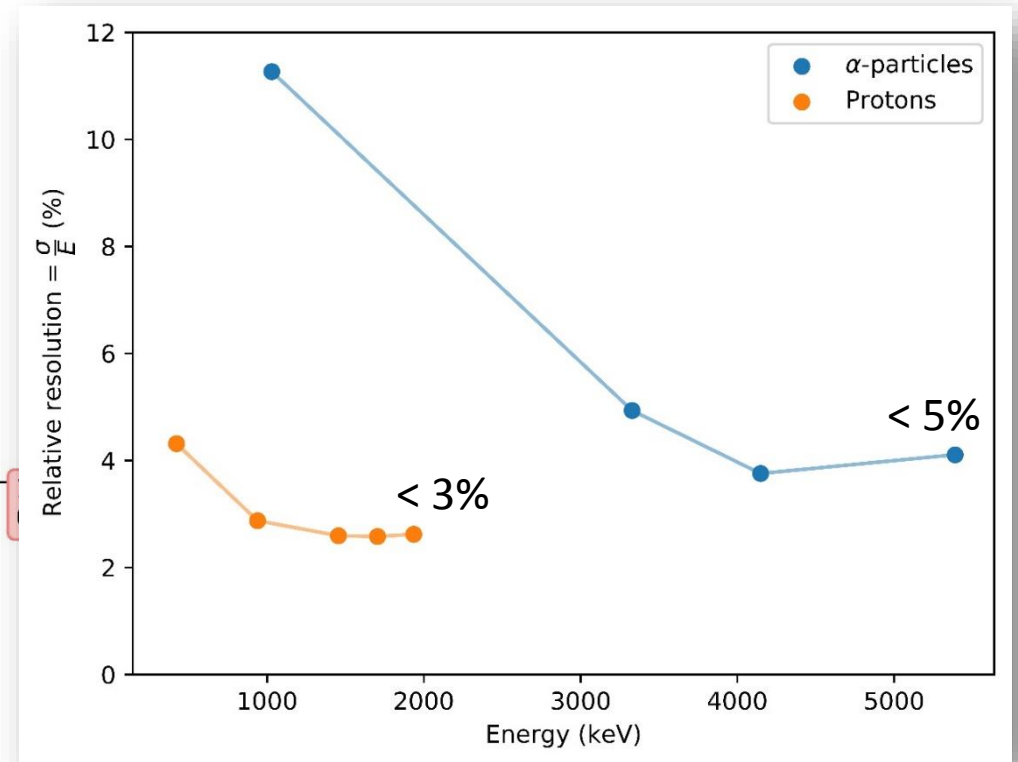
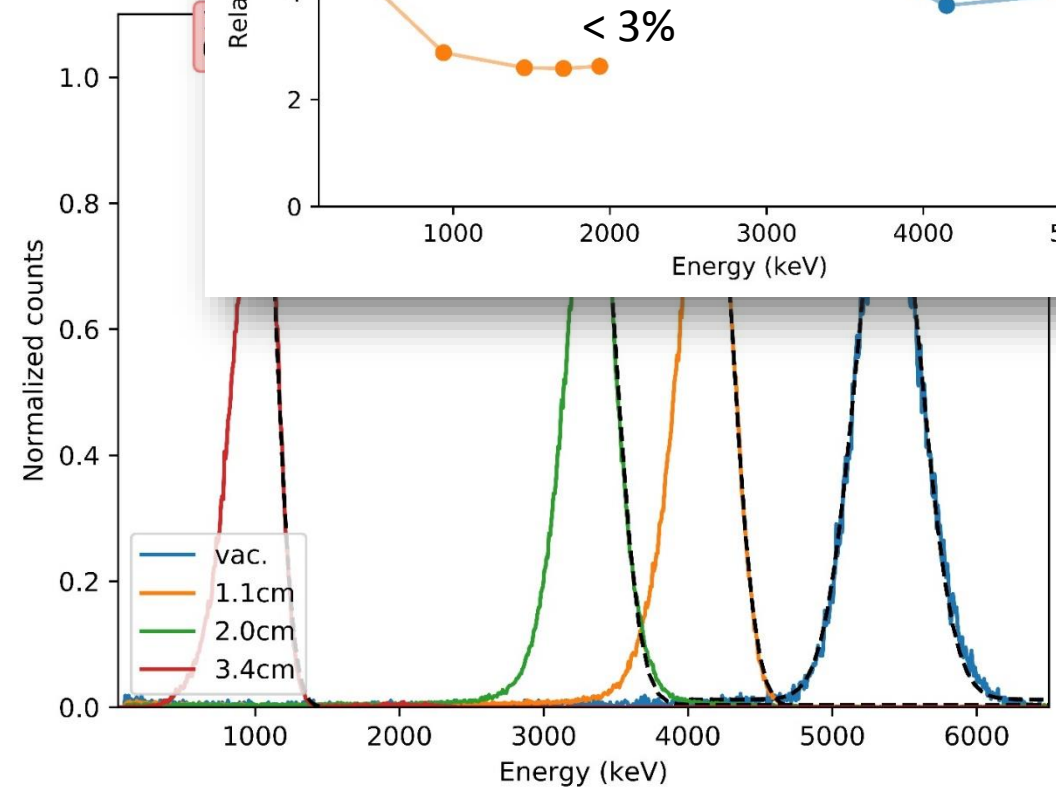
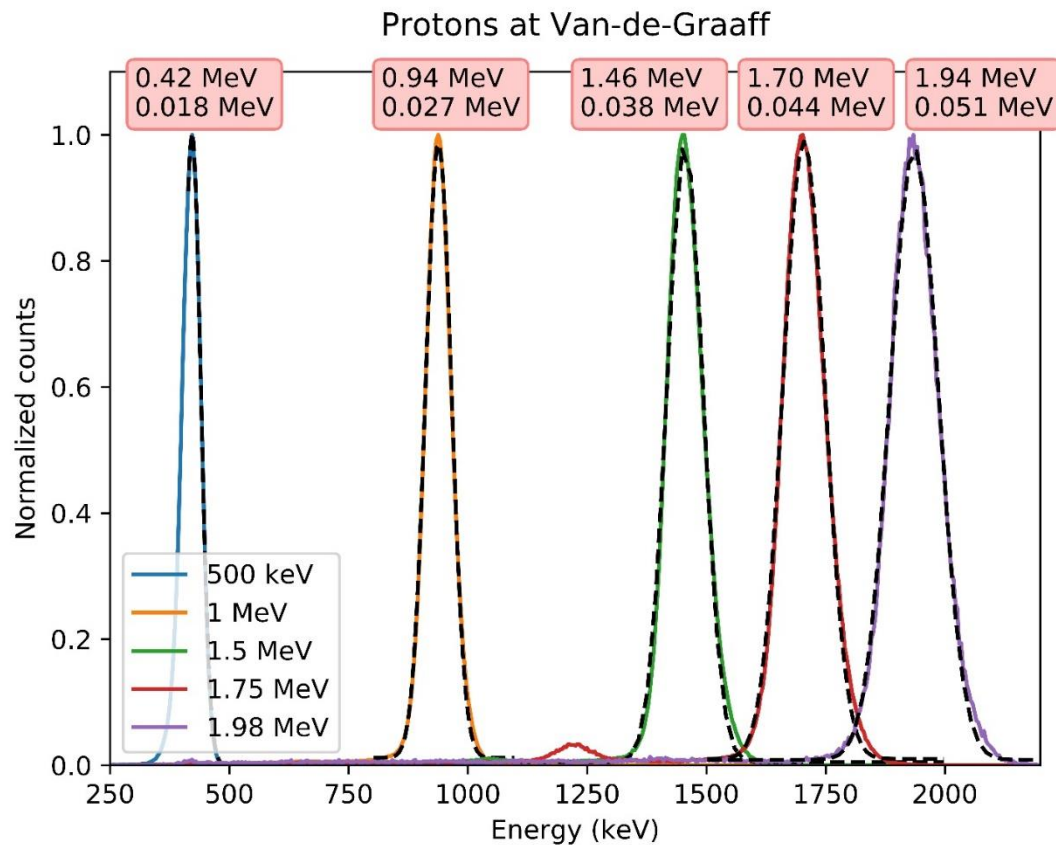
Design simulation predicts saturation at 950 ke $^{-}$



Reasonable agreement considering assumptions made in the simulation.

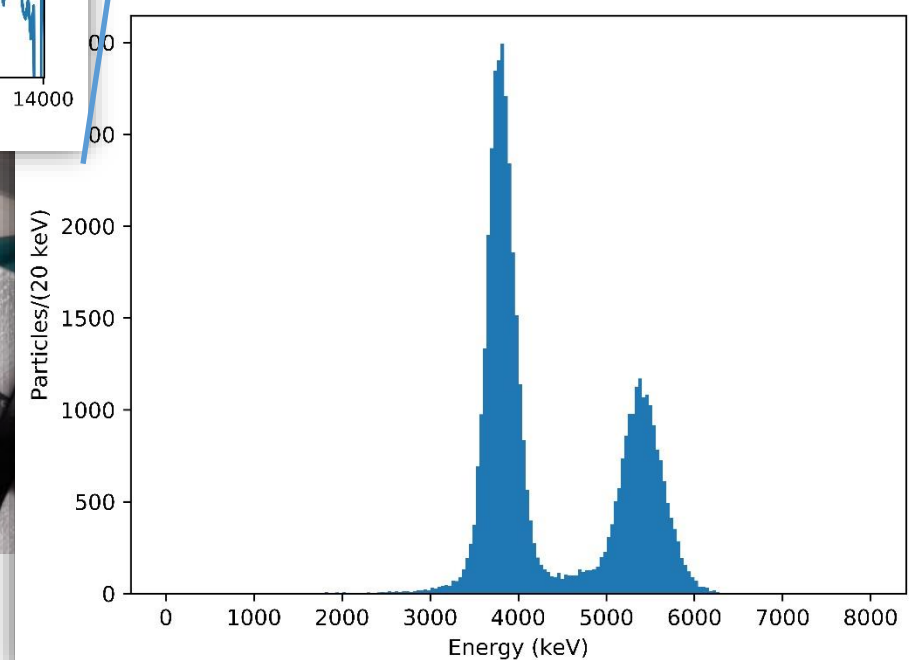
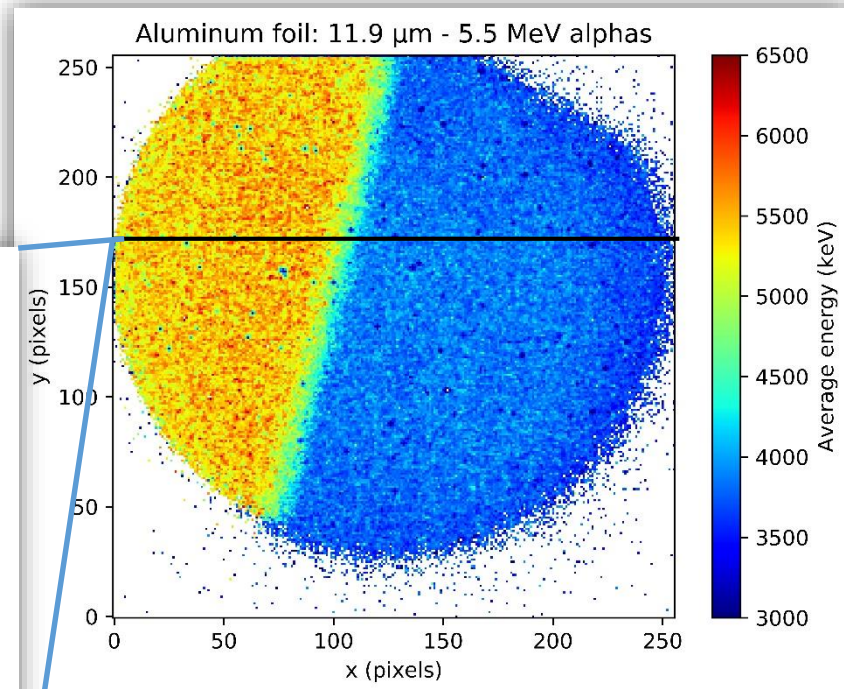
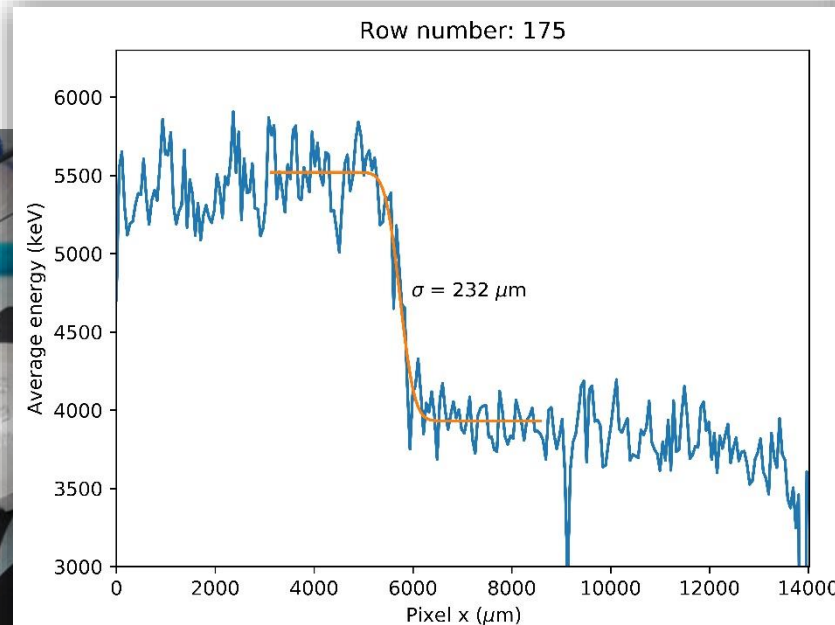
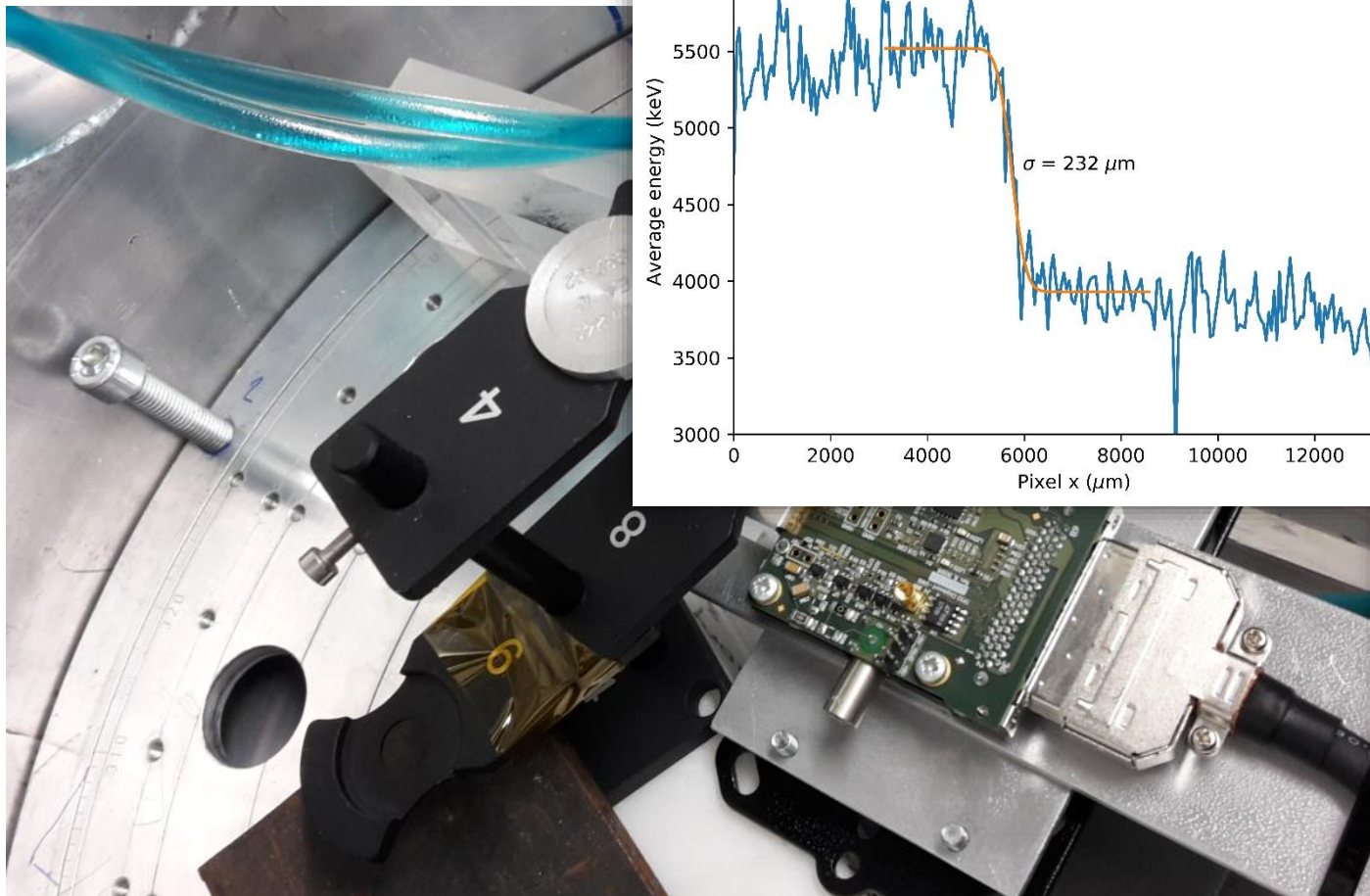
Results

Calibrated pixel energy response: (Corrected) energy spectra



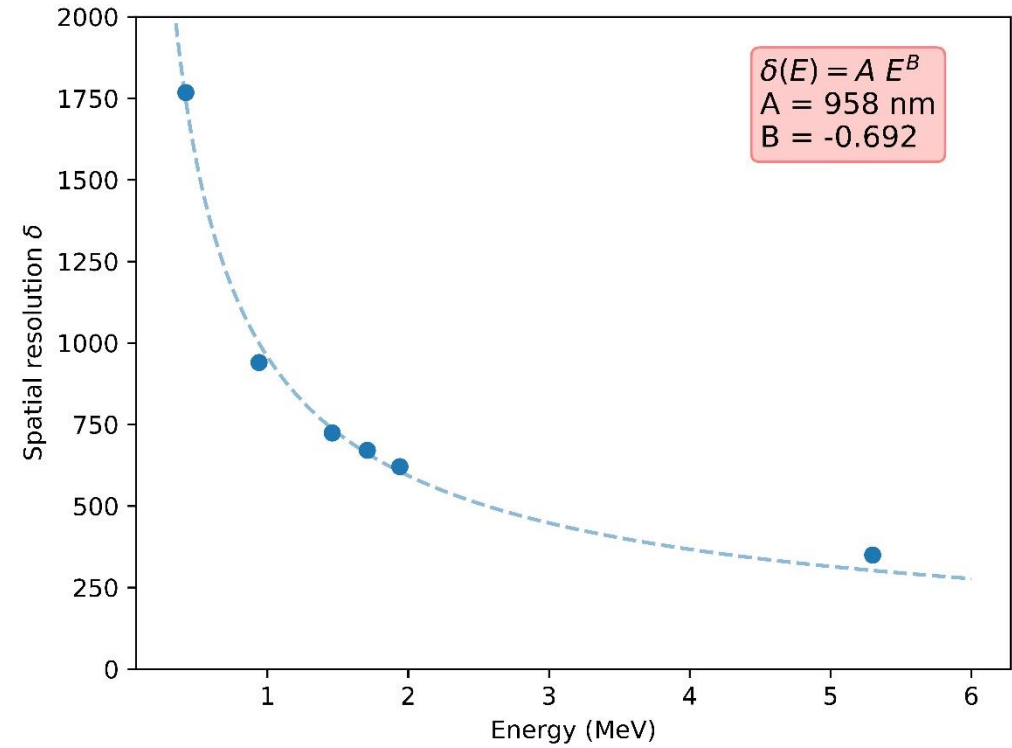
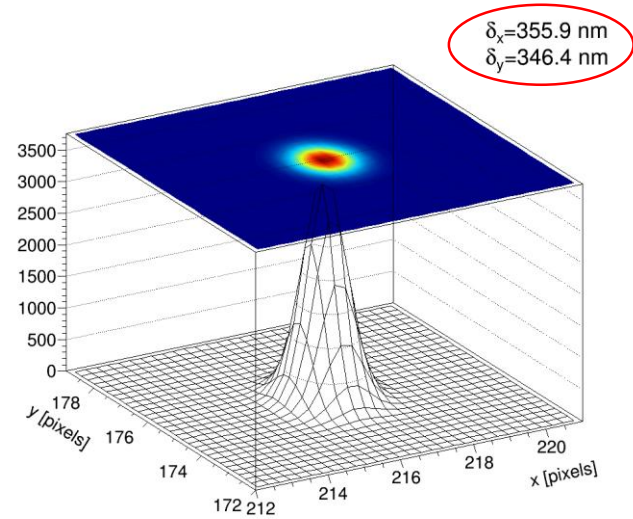
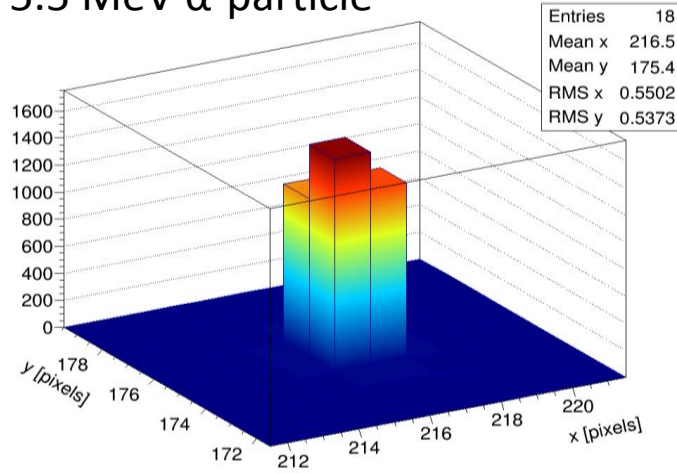
Application:

Spatially resolved α -particle energy loss in thin layers



Application: Subpixel spatial resolution

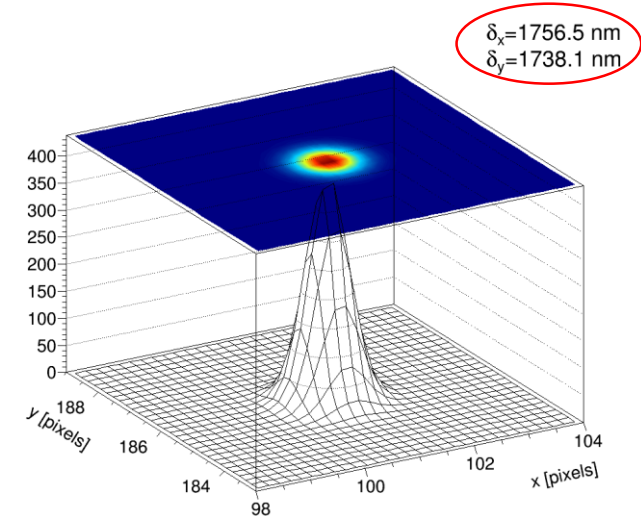
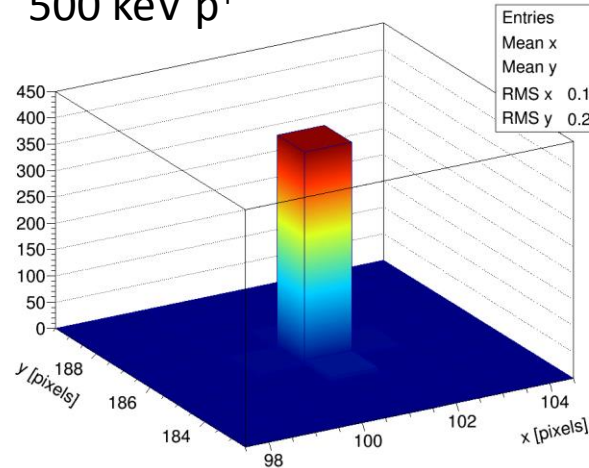
5.5 MeV α -particle



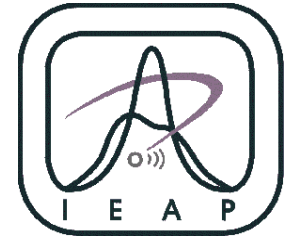
Spatial resolution determined from a 2D Gaussian fit to individual tracks.

→ Resolution defined as the error on the mean value

500 keV p^+



Conclusion



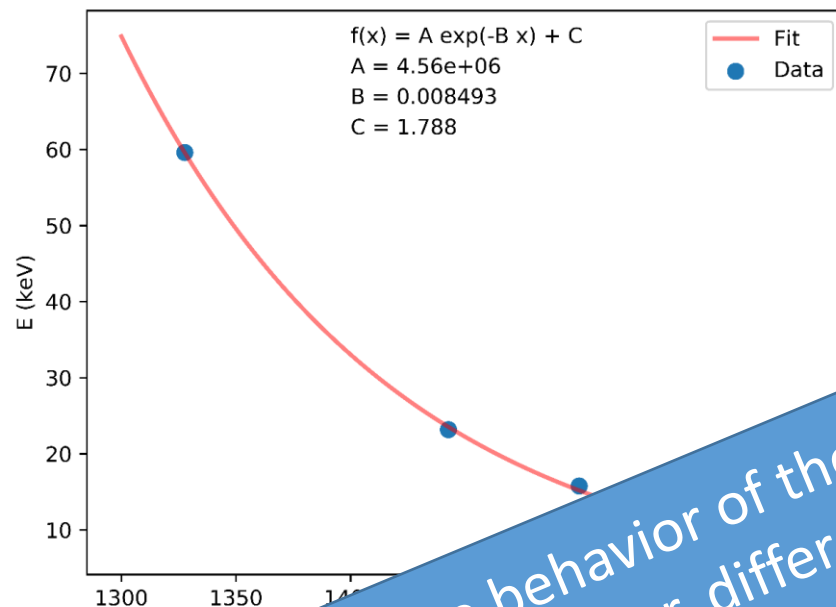
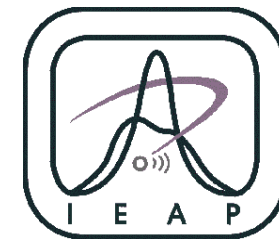
- The Timepix2 per pixel energy response has been studied in the range from 5 keV up to approximately 3.6 MeV to extend the calibration done with photons using a global correction function
- The following resolutions σ were achieved:
 - 1.6 keV for X-rays at 60 keV (1.4 keV for single pixel clusters)
 - ~55 keV for 2 MeV protons
 - ~220 keV for 5.5 MeV alpha particles

Thank you very much!

Back up

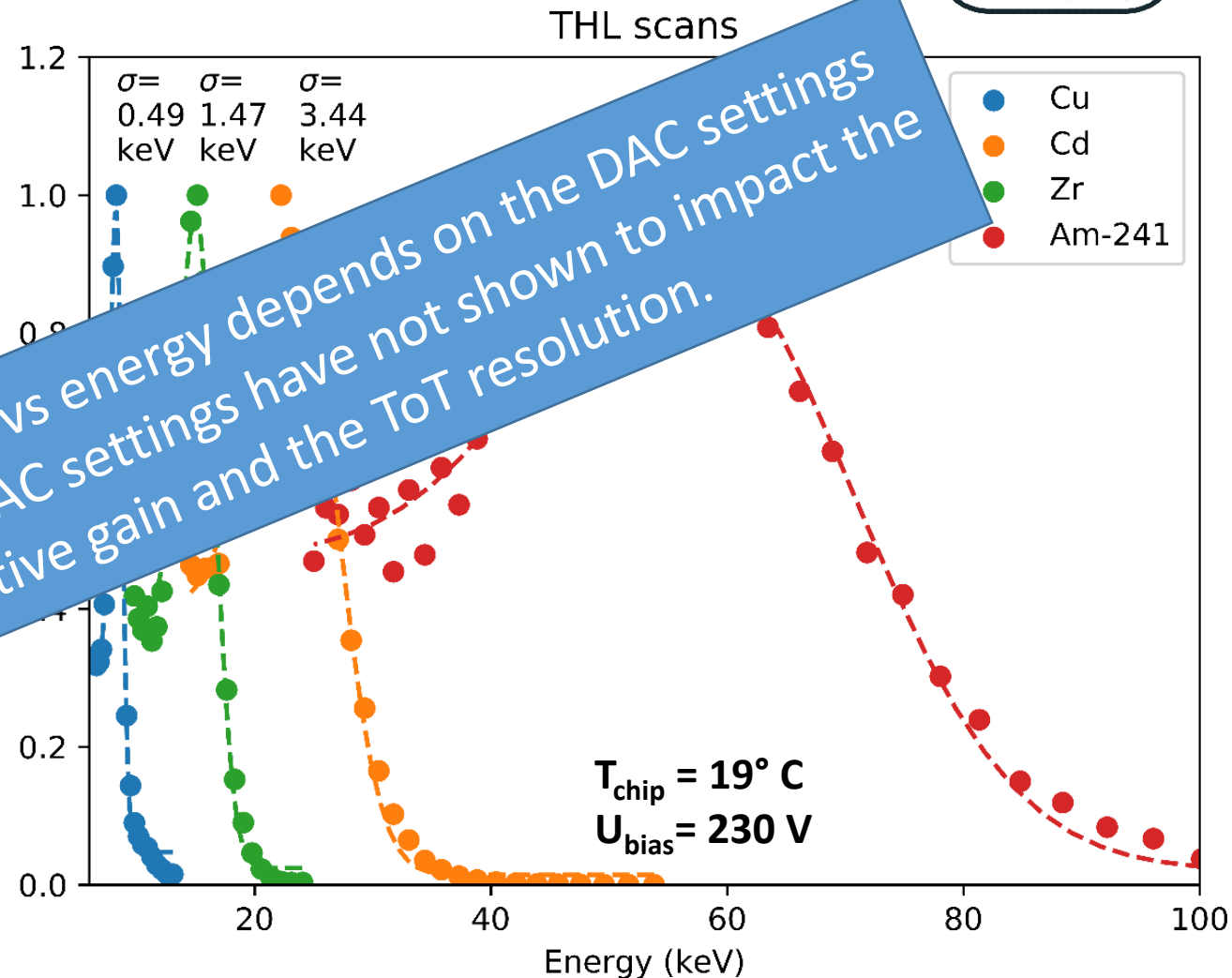
Energy calibration with photons:

THL scan results

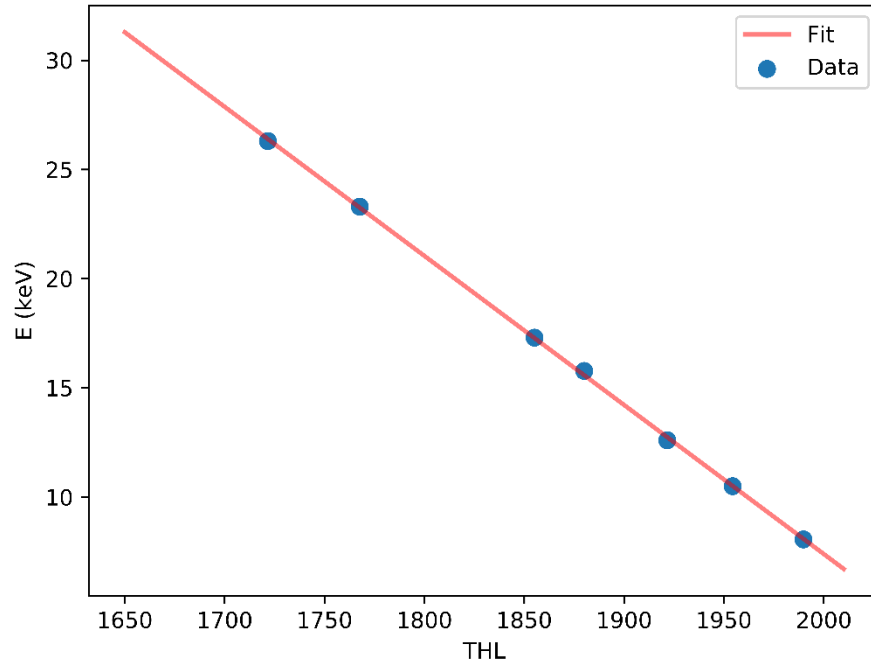
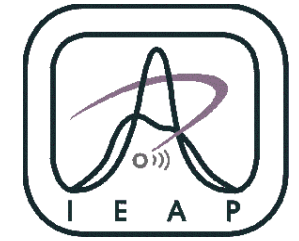


THL scan results
used for energy calibration
the THL scan results
THL at low energy was „noise“-free:
 $THL_{low} = 5 \text{ keV}$

Remark: The behavior of the THL vs energy depends on the DAC settings of the chip. However, different DAC settings have not shown to impact the behavior of the adaptive gain and the ToT resolution.



THL scan results – setting 2



Linear behavior of energy on THL
up to ~30 keV

